

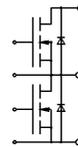
## SEMITRANS® M Power MOSFET Modules 120 A, 200 V, 17 mΩ

### SKM 120 B 020

Replaces discontinued SKM 224 A



### SEMITRANS 2



### Features

- N Channel, enhancement mode
- Short internal connections avoid oscillations
- Switching kW in less than 1 μs
- Isolated copper baseplate using Al<sub>2</sub>O<sub>3</sub> ceramic Direct Copper Bonding Technology (DCB)
- All electrical connections on top for easy busbaring
- Large clearances and creepage distances
- Material, clearances and creepage distances meet UL-specifications

### Typical Applications

- Switched mode power supplies
- DC servo and robot drives
- DC choppers
- UPS equipment
- Plasma cutting
- Not suitable for linear amplification

This is an electrostatic discharge sensitive device (ESDS).  
Please observe the international standard IEC 747-1, Chapter IX.

Absolute Maximum Ratings		Values	Units			
Symbol	Conditions <sup>1)</sup>					
V <sub>DS</sub>		200	V			
V <sub>DGR</sub>	R <sub>GS</sub> = 20 kΩ	200	V			
I <sub>D</sub>	T <sub>case</sub> = 25 °C	120	A			
	T <sub>case</sub> = 85 °C	87	A			
I <sub>DM</sub>		360	A			
V <sub>GS</sub>		± 20	V			
P <sub>D</sub>		500	W			
T <sub>J</sub> , T <sub>stg</sub>		- 55 ... +150	°C			
V <sub>isol</sub>	AC, 1 min	2 500	V			
humidity	DIN 40 040	Class F				
climate	DIN IEC 68 T.1	55/150/56				
Inverse Diode						
I <sub>F</sub> = - I <sub>D</sub>		120	A			
I <sub>FM</sub> = - I <sub>DM</sub>		360	A			
Characteristics		min.	typ.	max.	Units	
Symbol	Conditions <sup>1)</sup>					
V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0, I <sub>D</sub> = 0,25 mA	200	-	-	V	
V <sub>GS(th)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 1 mA	2,1	3,0	4,0	V	
I <sub>DSS</sub>	V <sub>GS</sub> = 0 } T <sub>J</sub> = 25 °C	-	50	250	μA	
	V <sub>GS</sub> = 200 V } T <sub>J</sub> = 125 °C	-	300	1000	μA	
I <sub>GSS</sub>	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0	-	10	100	nA	
R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 120 A	-	15	17	mΩ	
g <sub>fs</sub>	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 75 A	60	90	-	S	
C <sub>CHC</sub>	per MOSFET	-	-	100	pF	
C <sub>iss</sub>	V <sub>GS</sub> = 0	-	10,4	16	nF	
C <sub>oss</sub>	V <sub>DS</sub> = 25 V	-	2	4,5	nF	
C <sub>rss</sub>	f = 1 MHz	-	1	1,4	nF	
L <sub>DS</sub>		-	-	30	nH	
t <sub>d(on)</sub>	V <sub>DD</sub> = 100 V	-	120	-	ns	
t <sub>r</sub>	I <sub>D</sub> = 75 A	-	60	-	ns	
t <sub>d(off)</sub>	V <sub>GS</sub> = 10 V	-	240	-	ns	
t <sub>f</sub>	R <sub>GS</sub> = 3,3 Ω	-	40	-	ns	
Inverse Diode						
V <sub>SD</sub>	I <sub>F</sub> = 240 A, V <sub>GS</sub> = 0	-	1,2	1,5	V	
t <sub>rr</sub>	T <sub>J</sub> = 25 °C <sup>2)</sup>	-	400	-	ns	
	T <sub>J</sub> = 150 °C <sup>2)</sup>	-	700	-	ns	
Q <sub>rr</sub>	T <sub>J</sub> = 25 °C <sup>2)</sup>	-	5,0	-	μC	
	T <sub>J</sub> = 150 °C <sup>2)</sup>	-	8	-		
Thermal Characteristics						
R <sub>thjc</sub>	per MOSFET	-	-	0,25	°C/W	
R <sub>thch</sub>	per module	-	-	0,05	°C/W	
Mechanical Data						
M <sub>1</sub>	to heatsink	SI Units (M6)	4	-	5	Nm
		US Units	35	-	44	lb.in.
M <sub>2</sub>	for terminals	SI Units (M5)	2,5	-	3,5	Nm
		US Units	22	-	24	lb.in.
a			-	-	5x9,81	m/s <sup>2</sup>
w			-	-	250	g
Case	→ page B 5 - 42		D 70			

<sup>1)</sup> T<sub>case</sub> = 25 °C, unless otherwise specified.

<sup>2)</sup> I<sub>F</sub> = - I<sub>D</sub>, V<sub>R</sub> = 100 V, - di<sub>F</sub>/dt = 100 A/μs

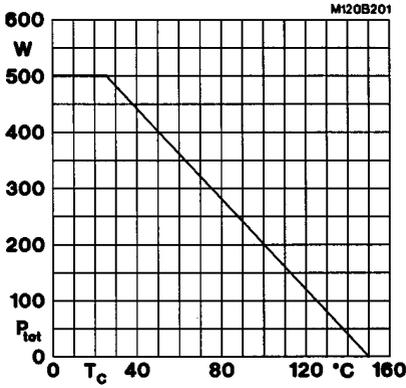


Fig. 1 Rated power dissipation vs. temperature

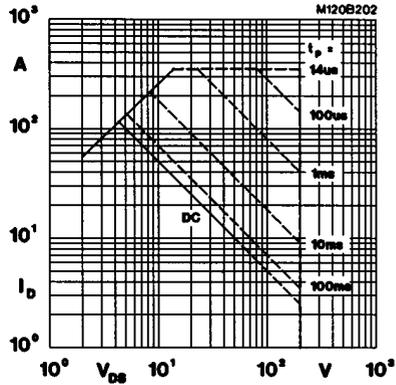


Fig. 2 Maximum safe operating area

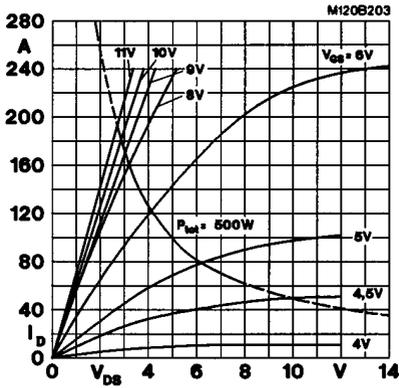


Fig. 3 Output characteristic

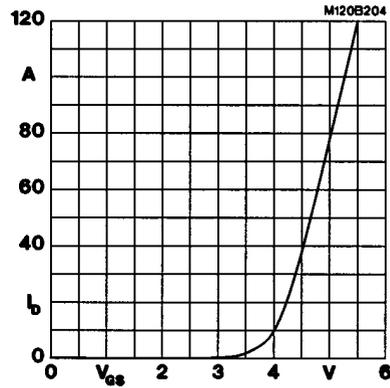


Fig. 4 Transfer characteristic

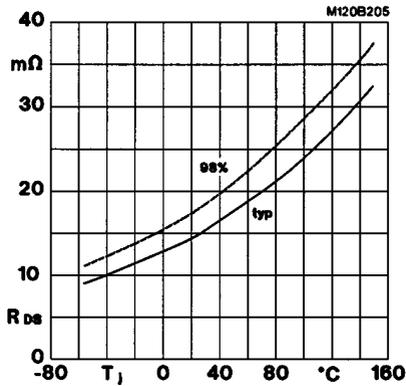


Fig. 5 On-resistance vs. temperature;  $I_D = 120$  A;  $V_{GS} = 10$  V

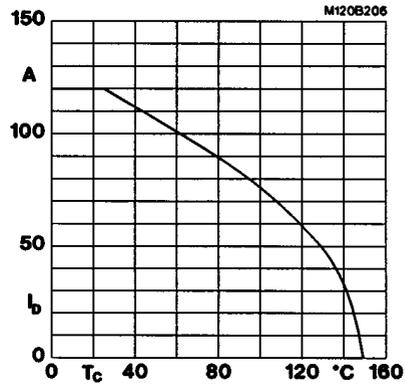


Fig. 6 Rated current vs. temperature;  $V_{GS} = 10$  V

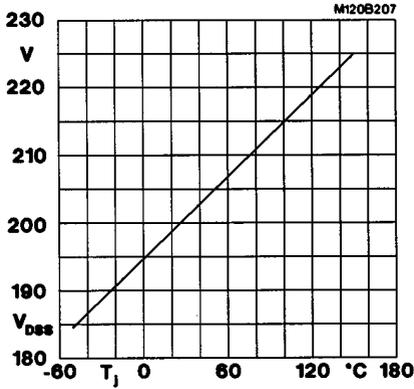


Fig. 7 Breakdown voltage vs. temperature

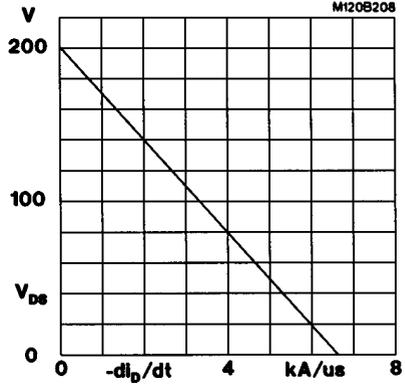


Fig. 8 Drain-source voltage derating

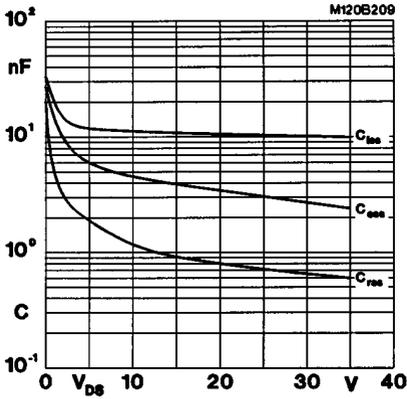


Fig. 9 Capacitances vs. drain-source voltage

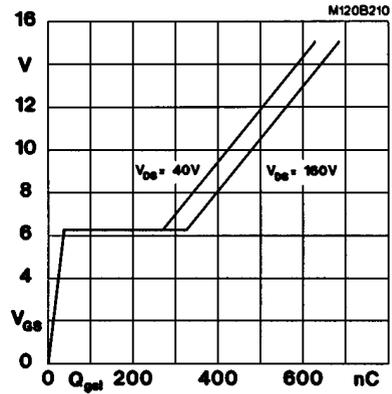


Fig. 10 Gate charge characteristic

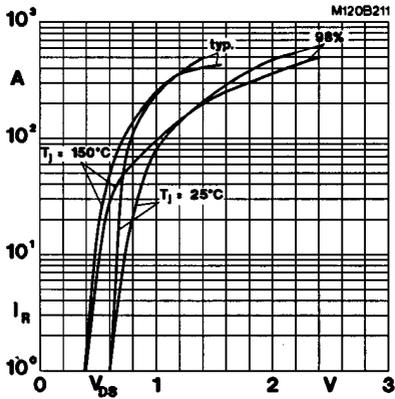


Fig. 11 Diode forward characteristic

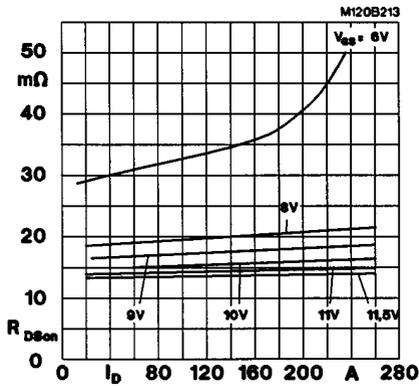


Fig. 13 On-resistance vs. drain current

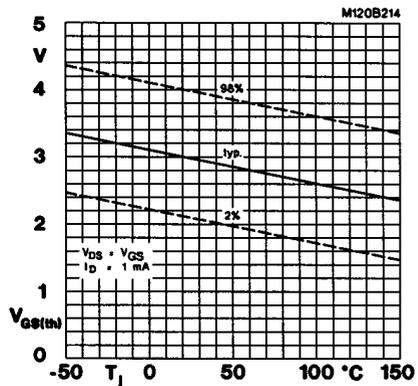


Fig. 14 Gate-source threshold voltage

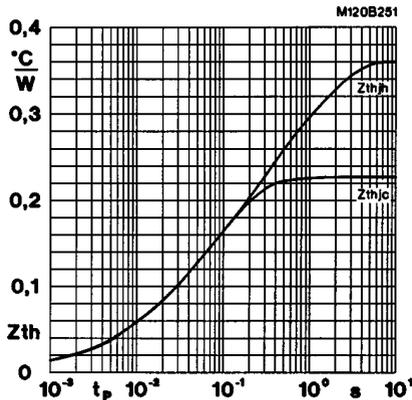


Fig. 51 Transient thermal impedance

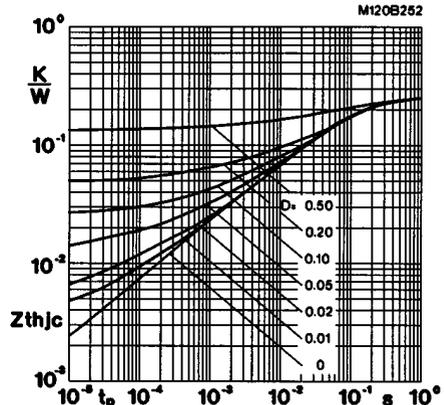


Fig. 52 Thermal impedance under pulse conditions

